

ACD-521D

Environment Test Report

Report NO: 12P020009

Summary	<p><input checked="" type="checkbox"/> Pass</p> <p><input type="checkbox"/> Fail</p> <p>Note : There is/are ____ defect(s) not list in the report, please check it in the DTS Website.</p> <p><input type="checkbox"/> Pass with Deviation</p> <p>Comment : _____</p>
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Issue date

2012-06-13

Approval

Vincent Chen

Test Engineer

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Test item list

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Testing Result

Num	Test item list	Result	Remark
1	Temperature rise test	Pass	
2	Temperature cycle operation test	Pass	
3	High temperature storage test	Pass	
4	Low temperature storage test	Pass	
5	Humidity test	Pass	
6	Cold start and hot start test	Pass	

Configuration of EUT

Num	Item	Spec
1.	Fanless Touch Panel	ACD-521D A0.1
	1. LCD	21.5".AUO. M215HW03 v1 1920x1080 250nits
	2. Touch Screen	MT9D215C55115 2048x2048
	3. A/D Board	S2523BVL Rev. DV
	4. Inverter	SAMPO YPWBGL2941DG
	5. I/O board	PER-T219 Rev. A0.3
	8. Test Software	Windows 7 / Run one Microsoft media player simultaneously
2.	Adapter	FSP FSP084-DMAA1

Temperature rise test

Test Date: 06-12-2012

Test Product: ACD-521D

Test Site: AAEMON QE Internal Lab.

Test Standard: Reference EN 61131-2(94), UL508 (94)

Temperature Measurement:

40 Channel Thermal Recorder:

YOKOGAWA Inc,

Model: ACD-521D

Date of Calibration: 10/12/2011

Serial Number: 12A323190

Test Condition:

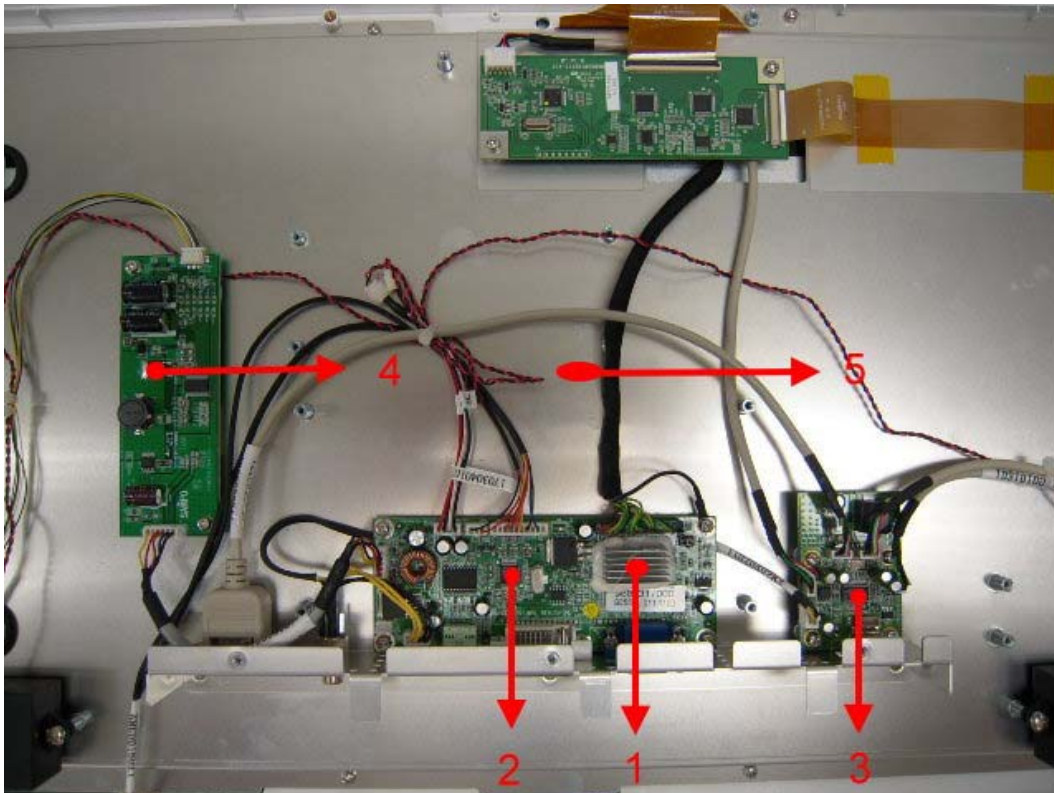
Ambient temperature: 40°C

Continuous running till thermal stability (within less than 1°C)

Test Software:

Windows 7 / Run one Microsoft media player simultaneously.

Terminal Recorder:



Temperature rise test



Temperature rise test

Thermal profile data:

Point	Temp. Stage(°C)	Spec	40	Note
A/D board				
01. U8 - REALTEK RTD2555 LH		85	79.9	
02. U4 - REALTEK RTD2120L A6M2002		85	74.6	
I/O board				
03. U2 - GL850G HH1GD08G22		85	63.9	
Inverter board				
04. Q2		125	74.3	
05. Control Box Inside Air Temperature		N/A	56.3	
06. Chamber Air Temperature		N/A	40.1	
07. Control Box Surface Temperature		N/A	44.8	
Note(*): 1. "Tc" indicates the component's case maximum temperature value specified in its datasheet. 2. "Tm" indicates the measured Tc value under working environmental temperature within product specification. 3. Judgment Criteria: - Fail : $T_m > T_c$; The measured value is over specification. - Margin Pass : $T_c > T_m > T_c - 5^\circ\text{C}$; The measured value is within specification with margin. It is strongly recommended to add thermal dissipation design for better reliability. - Pass : $T_m < T_c - 5^\circ\text{C}$; The measured value is with safety margin.				

Sample Configuration & Quantity Under Test:

Quantity: 1 (ACD-521D)

Test Result:

No problem was found during the temperature rise operation test.

Temperature cycle test

Test Date: 06-09 ~ 11-2012

Test Product: ACD-521D

Test Site: AAEON QE Internal Lab.

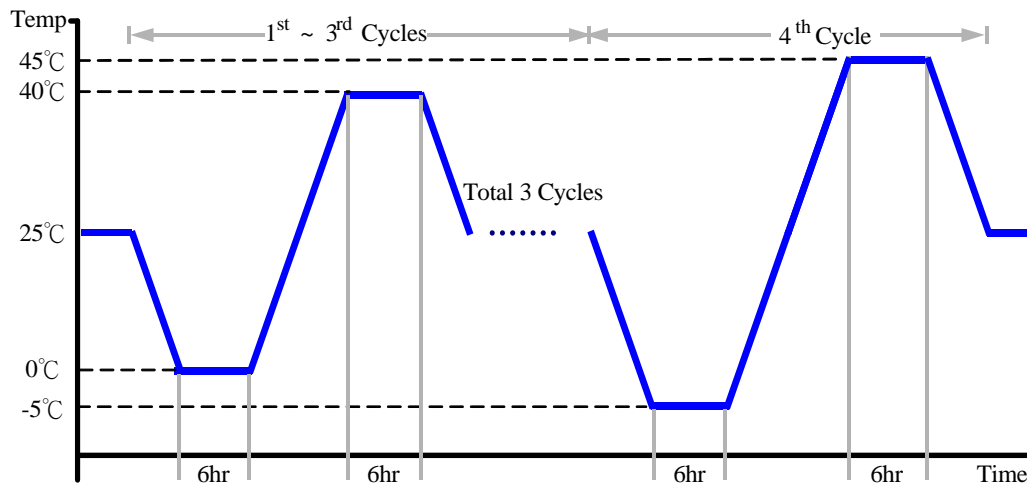
Test Standard: Reference IEC68-2-14 Testing procedures
Test N: Change of temperature Test

Test Equipment:

Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D75-100+LN2
Date of Calibration: 10/13/11
Serial Number: 6487KT

Test Condition:

1. Test Low Temperature: 0°C (1~3 cycles)
-5°C (4th cycle)
2. Test High Temperature: 40°C (1~3 cycles)
45°C (4th cycle)
3. Test dwell time: 6Hrs
4. Temperature slope: 2°C/min
5. Test cycle: 4 cycles
6. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (ACD-521D)

Test Result:

No problem was found during the temperature operation cycle test.

High temperature storage test

Test Date: 06-01 ~ 02-2012

Test Product: ACD-521D

Test Site: AAEON QE Internal Lab.

Test Standard: Reference IEC 68-2-2 Testing procedures
Test Bb: Dry Heat Test (Non-operation)

Test Equipment:

Programmable Temperature & Humidity Chamber

K.SON. INS. TECH. CORP.

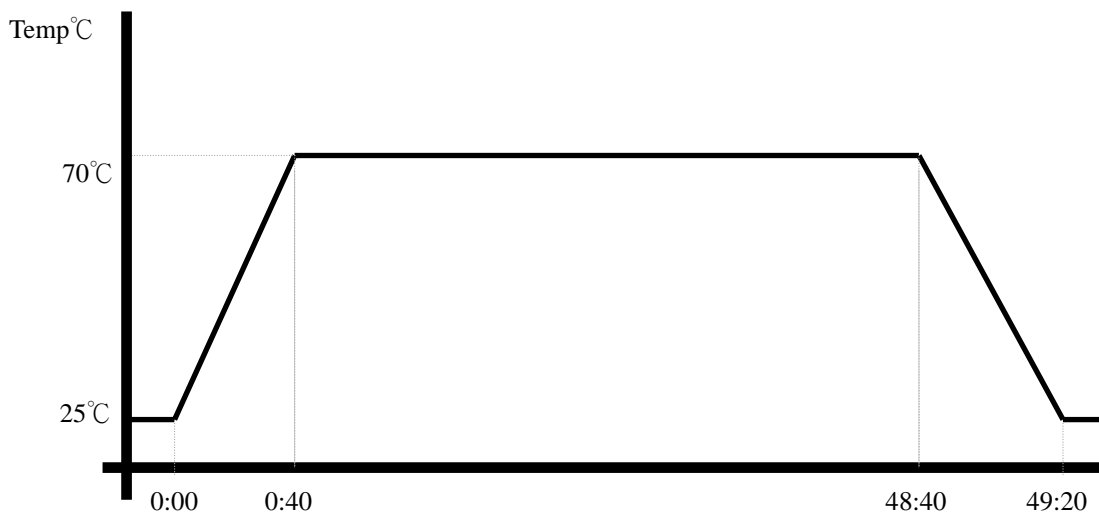
Model: THS-D75-100+LN2

Date of Calibration: 10/13/11

Serial Number: 6487KT

Testing Item:

1. Test Temperature: 70°C
2. Test Times: 48Hrs
3. Test Software: Windows 7 / Run one Microsoft media player simultaneously.
4. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (ACD-521D)

Test Result:

No problem was found after the high temperature storage test.

Low temperature storage test

Test Date: 06-03 ~ 04-2012

Test Product: ACD-521D

Test Site: AAeon QE Internal Lab.

Test Standard: Reference IEC 68-2-1 Testing procedures
Test Ab: Cold Test (Non-operation)

Test Equipment:

Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.

Model: THS-D75-100+LN2

Date of Calibration: 10/13/11

Serial Number: 6487KT

Testing Item:

1. Test Temperature: -20°C
2. Test Times: 48Hrs
3. Test Software: Windows 7 / Run one Microsoft media player simultaneously.
4. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (ACD-521D)

Test Result:

No problem was found after the low temperature storage test.

Humidity test

Test Date: 06-05 ~ 06-2012

Test Product: ACD-521D

Test Site: AAEON QE Internal Lab.

Test Standard: Reference IEC 68-2-3 Testing procedures
Test Ca: Damp heat, steady state (Non-operation)

Test Equipment:

Programmable Temperature & Humidity Chamber

K.SON. INS. TECH. CORP.

Model: THS-D75-100+LN2

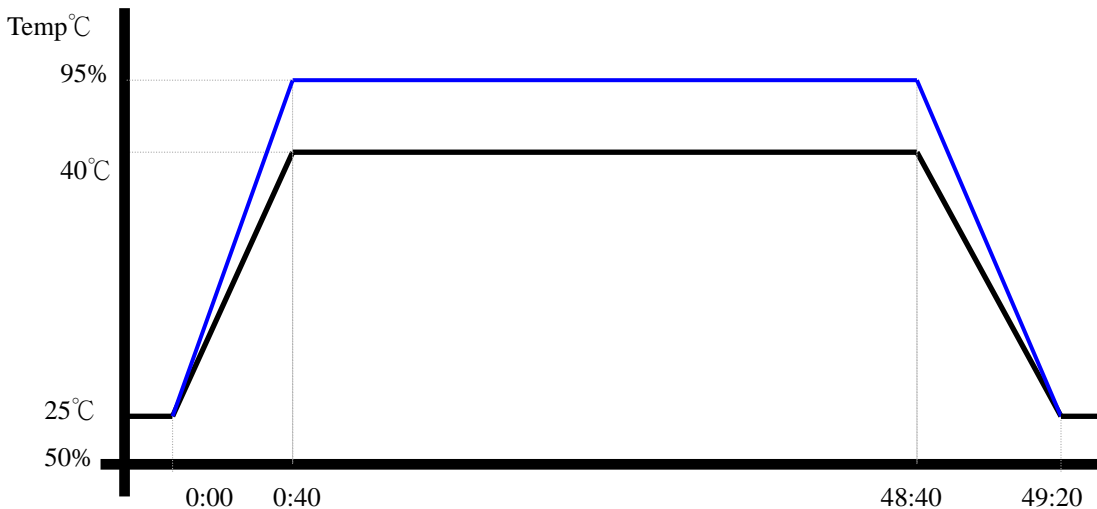
Date of Calibration: 10/13/11

Serial Number: 6487KT

Testing Item:

1. Test Temperature: 40°C
2. Test Humidity: 95%RH
3. Test Times: 48Hrs
4. Test Software: Windows 7 / Run one Microsoft media player simultaneously.
5. Test Environment Curve:

Humidity %



Sample Configuration & Quantity Under Test:

Quantity: 1 (ACD-521D)

Test Result:

No problem was found after the humidity storage test.

Cold start and hot start test

Test Date: 06-07 ~ 08-2012

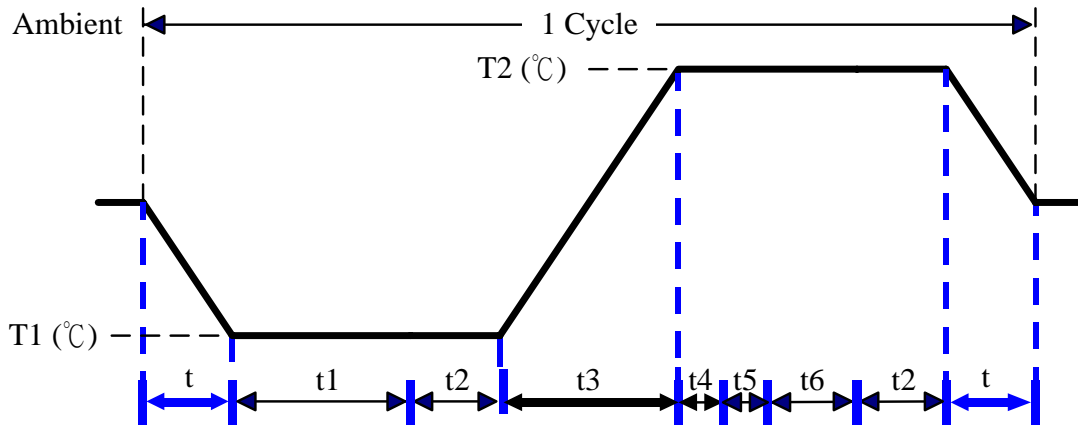
Test Product: ACD-521D

Test Site: AAEON QE Internal Lab.

Test Standard: Reference IEC 68-2-14 Testing procedures
Test N: Change of temperature Test

Test Equipment:
Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D75-100+LN2
Date of Calibration: 10/13/11
Serial Number: 6487KT

Test Condition:



Parameters	Description
T1	-5°C
T2	45°C
t1	4 hrs
t2, t6	2 hrs
t4, t5	1hrs
t, t3	2°C/min
n (Cycle)	1

t = temperature slope
t, t1, t6: Power Off
t2: Power on/off test 10 times (on 2 min / off 5min)
t3, t4: Run media player
t5: Win 7 Software restart test 3 times
Test Software: Windows 7

Test Result:

- a. No problem was found during the cold start test.
- b. No problem was found during the hot start test.